

**Search Notes**

Application/Control No.

10/065,171

Examiner

Cheukfan Lee

Applicant(s)/Patent under  
Reexamination

CHANG ET AL.

Art Unit

2627

**SEARCHED**

Class	Subclass	Date	Examiner
358	497,494, 474,471	3/21/2006	C.L.
	400,401		
	482,483		
	487,296		
	505,506		
	512-514		
	501,500		
250	239		
	234-236		
	216,208.1		
399	211,212		
355	40,41		
382	312		
	318,319		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search: see record	3/21/2006	C.L.
Inventor search		
Only related: Kao (6,762,864); Takahara (6,285,441); Hsiao (6,961,156); Takeuchi et al. (6,952,292)		
Onle related (cont.): Regetge (6,859,292); Sun et al. (6,072,602)		